

Low-level, low-noise high gain amplifier

The BFR 16 is an NPN silicon planar transistor designed for use in high performance, low level, low noise amplifier applications.

ELECTRICAL CHARACTERISTICS ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Symbol	Characteristic and test conditions	Min.	Typ.	Max.	Unit
h_{FE}	DC Current Gain (5) $I_C = 10 \mu\text{A}$ $V_{CE} = 5\text{V}$ $I_C = 100 \mu\text{A}$ $V_{CE} = 5\text{V}$ $I_C = 1 \text{ mA}$ $V_{CE} = 5\text{V}$ $I_C = 10 \text{ mA}$ $V_{CE} = 5\text{V}$	80	150	220	
$V_{BE(on)}$	Base - Emitter On Voltage $I_C = 1 \text{ mA}$ $V_{CE} = 5\text{V}$	0.5	0.64	0.70	V
$V_{CE(sat)}$	Collector Saturation Voltage (5) $I_C = 1 \text{ mA}$ $I_B = 0.1 \text{ mA}$		0.15	0.35	V
I_{CES}	Collector Reverse Current $V_{CE} = 50\text{V}$ $V_{EB} = 0$		0.1	10	nA
$I_{CES(150^\circ\text{C})}$	Collector Reverse Current $V_{CE} = 50\text{V}$ $V_{EB} = 0$		0.1	10	nA
I_{EBO}	Emitter Reverse Current $V_{EH} = 5\text{V}$ $I_C = 0$		0.1	10	nA
BV_{CES}	Collector to Emitter Breakdown Voltage $I_C = 10 \mu\text{A}$ $V_{EB} = 0$	60			V
BV_{EBO}	Emitter to Base Breakdown Voltage $I_E = 10 \mu\text{A}$ $I_C = 0$	6			V
IV_{CEO}	Collector to Emitter Sustaining Voltage (4 and 5) $I_C = 10 \text{ mA}$ $I_B = 0$	60			V
h_{fe}	Small Signal Current Gain ($f=1 \text{ kHz}$) $I_C = 1 \text{ mA}$ $V_{CE} = 5\text{V}$		350		
h_{ie}	Input Resistance ($f=1 \text{ kHz}$) $I_C = 1 \text{ mA}$ $V_{CE} = 5\text{V}$		10		k Ω
h_{oe}	Output Conductance ($f=1 \text{ kHz}$) $I_C = 1 \text{ mA}$ $V_{CE} = 5\text{V}$		17		μmho
h_{re}	Voltage Feedback Ratio ($f=1 \text{ kHz}$) $I_C = 1 \text{ mA}$ $V_{CE} = 5\text{V}$		4.3		$\times 10^{-4}$
h_{f0}	High Freq. Current Gain ($f=20 \text{ MHz}$) $I_C = 1 \text{ mA}$ $V_{CE} = 5\text{V}$	3.5	5		
C_{TE}	Emitter Transition Capacitance $I_C = 0$ $V_{EB} = 0.5\text{V}$		3.5	6	pF
C_{cbo}	Base - Collector Capacitance $I_F = 0$ $V_{CB} = 5\text{V}$		3.5	6	pF
NF	Wide Band Noise Figure (6) $I_C = 10 \mu\text{A}$ $V_{CE} = 5\text{V}$		1.5	4	dB
NF	Narrow Band Noise Figure (7) $I_C = 10 \mu\text{A}$ $V_{CE} = 5\text{V}$		1	4	dB

ABSOLUTE MAXIMUM RATINGS (1) ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Voltages and Currents

Collector to Emitter (4)	V_{CEO}	60	V
Collector to Emitter	V_{CES}	60	V
Emitter to Base	V_{EBO}	8	V
DC Collector Current	I_C	50	mA

Temperatures

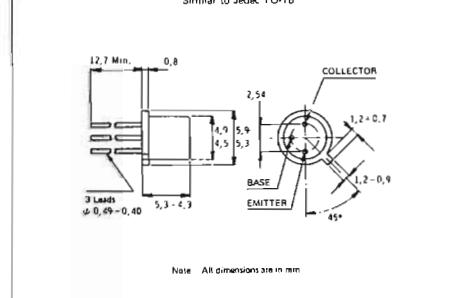
Storage Temperatur	TSTG	-55°C to 200°C
Junction Temperature	T_J	200°C
Lead Temperature (Soldering 10 sec.)	T_L	260°C

Power (2 - 3)

Dissipation at 25°C Case Temperature	P_D	1.2 W
Dissipation at 25°C Ambient Temperature	P_D	0.36 W

PHYSICAL DIMENSIONS

Similar to Jede TO-18



Note: All dimensions are in mm

NOTES:

- These ratings are limiting values above which the serviceability of any individual semiconductor device may be impaired.
- These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.
- These ratings give a maximum junction temperature of 200°C and junction-to-case thermal resistance of 146°C/W (derating factor of 6.9 mW/°C); junction-to-ambient thermal resistance of 486°C/W (derating factor of 2.1 mW/°C).
- These ratings refer to a high-current point where collector-to-emitter voltage is lowest. For more information send for SGS - AR 5.
- Measured under pulse conditions: pulse length = 300 μsec ; duty cycle = 1%.
- $R_S = 10 \text{ k}\Omega$; Power Bandwidth of 15.7 kHz with 3 dB points at 10 Hz and 10 kHz.
- $f = 1 \text{ kHz}$; $R_g = 10 \text{ k}\Omega$; Power Bandwidth of 200 Hz.